

Application/Control No.	Applicant(s)/Patent under Reexamination				
09/684,946	CASWELL ET AL.				
Examiner	Art Unit				
Benjamin E. Lanier	2132				

ISSUE CLASSIFICATION									
ORIGI	INAL	CROSS REFERENCE(S)							
CLASS	SUBCLASS	CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)							
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INTERNATIONAL O	CLASSIFICATION	380	SD	258	• •				
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Berliann E.	anier for S Examiner) (Date	8/17/2	6	くらべた	$\mathcal{D}_{c}$		Total Claims Allov	ved: 1 🔿	
(Assistant	Examiner) (Date	) 11705		GILBERTO		- [ ]		12	
Kim lab-te	DAG BULK	MM		RVISORY PA			O.G.	O.G.	
TIME I VILLE		LAMA)		CHNOLOGY mary Examiner)		(Date) I	Print Claim(s)	Print Fig.	
(Legai Instrum	ents Examiner)	コダナル	つ ""	ary Examiner)	X	124/05			
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Claims ren	umbered in the s	ame orde	r as preser	ited by app	icant	☐ CPA	T.D.	R.1.47	
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Final	Final	Final	Original	Final Original		Final	Final	Final	
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2 2 3	32		62 63	92	┥ ├	122 123	152	182	
3 4	34		64	94	┪ ┞	124	154	184	
4 5	35		65	95	] [	125	155	185	
5 6	36		66	96	<b>↓</b>	126	156	186	
7 8	37		67 68	97	┨	127 128	157	187	
4 9	39		69	98	┨	128	158	188	
10	40		70	100	1	130	160	190	
9 11	41		71	101	] [	131	161	191	
io 12	42		72	102	↓ [	132	162	192	
13 14	43		73	103 104	-	133	163	193	
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16	46		76	106	1 }	136	166	195	
17	47		77	107	] [	137	167	197	
18	48		78	108	] [	138	168	198	
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22	52		82	112	┪ ┞	142	172	201	
23	53		83	113	]	143	173	203	
24	54		84	114	] [	144	174	204	
25	55		85	115	<b>↓                                    </b>	145	175	205	
26	56 57		86 87	116	-	146 147	176 177	206	
28	58		88	117	┨	147	177	207	
29	59		89	119	1	149	179	209	
30	60		90	120		150	180	210	